

From Polarimetry to Anomalous Triple Gauge Couplings A Precision Study at the ILC

11th Annual Meeting of the Helmholtz Alliance "Physics at the Terascale",
LC Forum, DESY

Robert Karl

¹Deutsches Elektronen-Synchrotron (DESY)

²University of Hamburg

27.11.2017



PIER
Helmholtz
Graduate
School

A Graduate Education Program
of Universität Hamburg
in Cooperation with DESY



Outline

Beam Polarization Determination via Cross Section Measurement

Introduction

Toy Measurement Results

Usage of Additional information from the Angular Distribution

Electroweak Precision Measurements

Total Chiral Cross Section Measurement

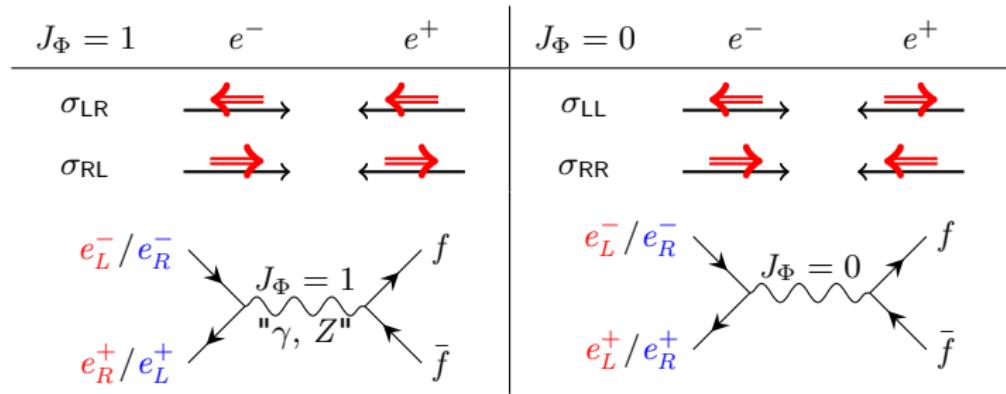
Anomalous Triple Gauge Couplings

Conclusion



Polarization at a e^-e^+ Collider

- ▶ Helicity is the projection of the spin vector on the direction of motion
- ▶ In case of massless particles, helicity is equal to chirality
- ▶ If $E_{\text{kin}} \gg E_0 \quad \rightarrow \quad m_e \approx 0$



- ▶ For a bunch of particles the polarization is defined as:

$$P := \frac{N_R - N_L}{N_R + N_L}$$

Beam Polarization Dependent Cross Section

- Theoretical polarized cross section in general:

$$\begin{aligned}\sigma_{\text{theory}}(P_{e^-}, P_{e^+}) = & \frac{(1-P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \sigma_{LL} + \frac{(1+P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \sigma_{RR} \\ & + \frac{(1-P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \sigma_{LR} + \frac{(1+P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \sigma_{RL}\end{aligned}$$

- Nominal ILC Polarization values

$$\underbrace{P_{e^-}^- = -80\%}_{\text{"left"-handed } e^- \text{-beam}},$$

$$\underbrace{P_{e^-}^+ = 80\%}_{\text{"right"-handed } e^- \text{-beam}},$$

$$\underbrace{P_{e^+}^- = -30\%}_{\text{"left"-handed } e^+ \text{-beam}},$$

$$\underbrace{P_{e^+}^+ = 30\%}_{\text{"right"-handed } e^+ \text{-beam}},$$

- Cross section of the 4 polarization configurations

$$\sigma_{--} := \sigma(P_{e^-}^-, P_{e^+}^-)$$

$$\sigma_{++} := \sigma(P_{e^-}^+, P_{e^+}^+)$$

$$\sigma_{-+} := \sigma(P_{e^-}^-, P_{e^+}^+)$$

$$\sigma_{+-} := \sigma(P_{e^-}^+, P_{e^+}^-)$$

- $\sigma_{LL}, \sigma_{RR}, \sigma_{LR}, \sigma_{RL}$ calculated by WHIZARD including ISR and beam spectrum



Polarized Cross Section Measurement

- Measured polarized cross section:

$$\sigma_{\text{data}} = \frac{D - \mathfrak{B}}{\varepsilon \cdot \mathcal{L}}$$

D : Number of signal events

\mathfrak{B} : Background expectation value

ε : Detector selection efficiency

\mathcal{L} : Integrated luminosity

Remark:

All of them can variate between the different data sets (σ_{-+} , σ_{+-} , σ_{--} , σ_{++})

- Uncertainty of the polarized cross section calculated via error propagation

e.g. $(\Xi_{\mathcal{L}})_{ij} = \text{corr}(\sigma_i^{\mathcal{L}}, \sigma_j^{\mathcal{L}}) \frac{\partial \sigma_i}{\partial \mathcal{L}_i} \frac{\partial \sigma_j}{\partial \mathcal{L}_j} \Delta \mathcal{L}_i \Delta \mathcal{L}_j \quad i, j \in \{-+, +-, --, ++\}$

$$\Xi := \underbrace{\Xi_D}_{\substack{\text{statistical} \\ \text{uncertainty}}} + \underbrace{\Xi_{\mathfrak{B}} + \Xi_{\varepsilon} + \Xi_{\mathcal{L}}}_{\substack{\text{systematic uncertainty}}};$$

Remark:

Statistical uncertainty is always uncorrelated: $\text{corr}(\sigma_i^D, \sigma_j^D) \equiv \delta_{ij}$

And it is determined by Poisson fluctuations:

$$\Delta D \equiv \sqrt{D}$$

Fit Procedure

- ▶ Consider the 4 ILC polarization as independent:

$$\underbrace{P_{e^-}^- = -80\%}_{\text{"left"-handed } e^- \text{-beam}}$$

$$\underbrace{P_{e^-}^+ = 80\%}_{\text{"right"-handed } e^- \text{-beam}}$$

$$\underbrace{P_{e^+}^- = -30\%}_{\text{"left"-handed } e^+ \text{-beam}}$$

$$\underbrace{P_{e^+}^+ = 30\%}_{\text{"right"-handed } e^+ \text{-beam}}$$

- ▶ Using the method of least squares:

$$\chi^2 = \sum_{\text{process}} (\vec{\sigma}_{\text{data}} - \vec{\sigma}_{\text{theory}})^T \Xi^{-1} (\vec{\sigma}_{\text{data}} - \vec{\sigma}_{\text{theory}});$$

$$\vec{\sigma} := \begin{pmatrix} \sigma_{-+} & \sigma_{+-} & \sigma_{--} & \sigma_{++} \end{pmatrix}^T$$

- ▶ Determine the polarization:

- ▶ Find $P_{e^-}^-$, $P_{e^-}^+$, $P_{e^+}^-$, $P_{e^+}^+$ that minimizes χ^2
- ▶ Parameter uncertainties provides also the polarization uncertainties:

$$\Delta P_{e^-}^-, \Delta P_{e^-}^+, \Delta P_{e^+}^-, \Delta P_{e^+}^+$$

Process	Channel
single W^\pm	$e\nu l\nu$, $e\nu q\bar{q}$
WW	$q\bar{q}q\bar{q}$, $q\bar{q}l\nu$, $l\nu l\nu$
ZZ	$q\bar{q}q\bar{q}$, $q\bar{q}ll$, $llll$
$ZZWW\text{Mix}$	$q\bar{q}q\bar{q}$, $l\nu l\nu$
Z	$q\bar{q}$, ll

Beam Polarization Determination via Cross Section Measurement

Introduction

Toy Measurement Results

Usage of Additional information from the Angular Distribution

Electroweak Precision Measurements

Total Chiral Cross Section Measurement

Anomalous Triple Gauge Couplings

Conclusion



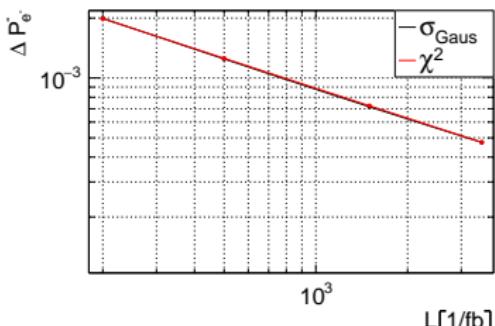
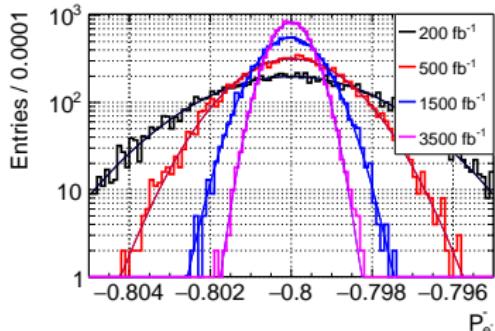
Toy Monte Carlo

Toy measurement:

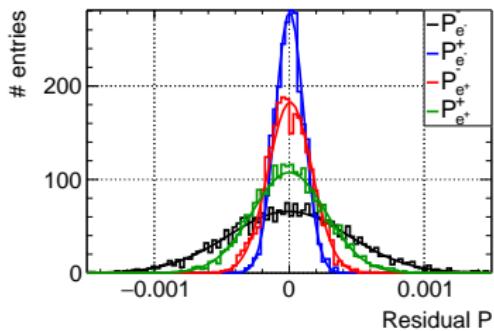
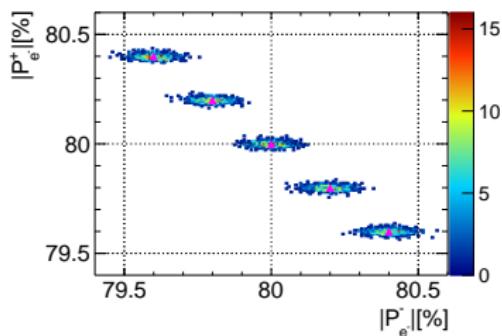
- ▶ Signal expectation value:
 $\langle D \rangle = \sigma_{\text{theory}} \cdot \varepsilon \cdot \mathcal{L} + \mathfrak{B}$
- ▶ One toy experiment:
 Random Poisson number around each $\langle D \rangle$
- ▶ Determine $P_{e^\pm}^\pm$ for each toy experiment
- ▶ Simplified case for illustration:
 - ▶ $\mathfrak{B} = 0$ and $\varepsilon = 1$
 - ▶ Statistical uncertainties only
 - ▶ Using 10^4 toy measurements

Polarization uncertainty:

- ▶ Gaussian fit of toy measurement distribution
- ▶ Perfect match between Gaussian width and polarization error



Testing for a Non-Perfect Helicity Reversal



► Variation in the absolute polarization

- ▶ Toy Measurement for 5 different polarization discrepancies for both beams (**magenta triangle**)
- ▶ Nominal initial polarizations: $|P_{e^-}| = 80\%$, $|P_{e^+}| = 30\%$
- ▶ Statistical uncertainties only

► χ^2 -minimization:

- ▶ No difference between the residuals:
 - ▶ with equal absolute values (solid lines) and
 - ▶ without equal absolute values (histograms)
- ▶ Correct determination of the 4 polarization values

✓ Can compensate for a non-perfect helicity reversal

Systematic Uncertainties and their Correlations

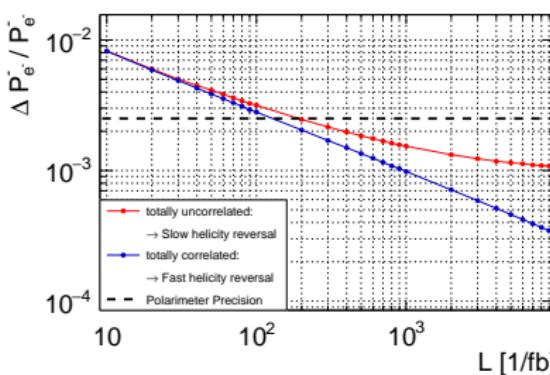
► Systematic Uncertainties are *inter alia* influenced by

- ▶ Detector calibration and alignment
- ▶ Machine performance
- ⇒ Time dependent uncertainties

► Example:

$$\Delta\varepsilon/\varepsilon = 0.5\%; \quad \varepsilon = 0.8;$$

$$\Delta\mathcal{L}/\mathcal{L} = 1 \cdot 10^{-4}$$



► Data set are taken one at a time:

- ▶ Slow frequency of helicity reversals: \mathcal{O} (weeks to months)
- ▶ Data sets are independent
- Completely uncorrelated
- ✗ Lead to saturation at systematic precision

► Data sets taken concurrently:

- ▶ Fast frequency of helicity reversals: \mathcal{O} (train-by-train)
- Faster than changes in calibration/alignment
- Generate correlations
- ✓ Lead to cancellation of systematic uncertainties

Beam Polarization Determination via Cross Section Measurement

Introduction

Toy Measurement Results

Usage of Additional information from the Angular Distribution

Electroweak Precision Measurements

Total Chiral Cross Section Measurement

Anomalous Triple Gauge Couplings

Conclusion

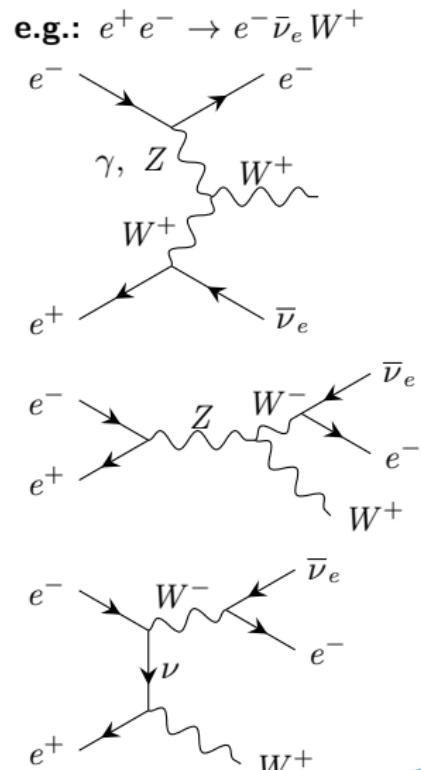


Consideration of the Addition Information from the Angular Distribution

- ▶ Total cross section
 - ▶ Rely on theoretical calculation
 - ⇒ Susceptible to BSM effects
- ▶ Differential cross section
 - ▶ Additional usage of the angular information
 - ⇒ Increase of the robustness against BSM effects
- ▶ Currently implemented processes for differential cross section

Process	Channel
single W^\pm	$e\nu l\nu$, $e\nu q\bar{q}$
WW	$q\bar{q}q\bar{q}$, $q\bar{q}l\nu$, $l\nu l\nu$
Z	$q\bar{q}$, ll

- ▶ The other processes used with total cross section
- ⇒ This can easily be changed!

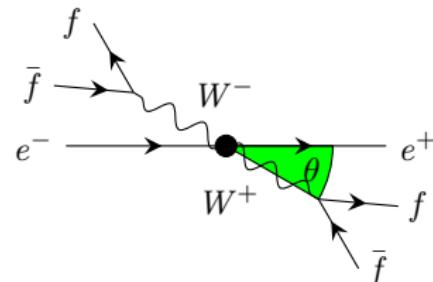


Usage of the Differential Polarized Cross Section

Choice of the angle:

- ✓ Individual for each process and channel
- ✓ High dependence of the angular distribution on the chiral structure
- ✗ Angle has to be well measurable
→ Not jet verified for all processes

e.g.: $e^+ e^- \rightarrow W^+ W^- \rightarrow q\bar{q} l\nu$

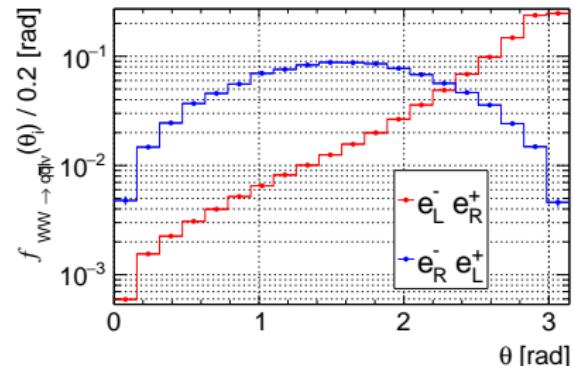


Bin-wise cross section calculation:

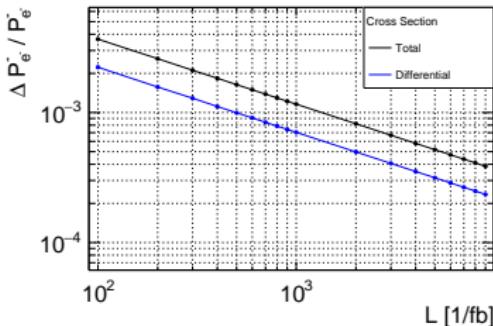
$$\begin{aligned} \text{differential cross section} &\quad \text{cross section of the } i\text{-th bin} \\ \overbrace{\delta\sigma/\partial\theta} &\rightarrow \overbrace{\delta_i\sigma_{\text{data}}} := \delta_i N / \mathcal{L} \\ &\rightarrow \delta_i\sigma_{LR} := f_{LR}(\theta_i) \cdot \sigma_{LR} \end{aligned}$$

Analog: RL, LL, RR

- $\delta_i N = (\delta_i D - \delta_i \mathfrak{B})/\delta_i \varepsilon$: events of i -th bin
- $f(\theta_i)$: fraction of the total cross section



Statistical Results with Differential Cross Section



Using the following configuration:

- ▶ Using 20 equal bins in a θ range of $[0, \pi]$
- ▶ Signal determination bin-by-bin:

$$\langle \delta_k D \rangle = \delta_k \sigma_{\text{theory}} \cdot \delta_k \varepsilon \cdot \mathcal{L} + \delta_k \mathfrak{B}$$
- ▶ For the start:
 Statistical error only + no background
- ▶ Using H-20 integrated luminosity sharing due to energy

- ▶ Differential cross section have a lower statistic uncertainty:
 - ▶ Expectation of $\delta_k D$ can be for some bins $\mathcal{O}(1)$
 - ▶ Some zero diagonal entries of the covariance matrix \rightarrow not invertible
 - ⇒ Dropping χ^2 -terms with $\delta_k D = 0$
- ▶ Further steps:
 - ▶ Implementing differential cross section for all processes
 - ▶ Implementing multi-differential cross section
 (only implemented for $e^+ e^- \rightarrow q\bar{q}\mu\nu$)

Beam Polarization Determination via Cross Section Measurement

Introduction

Toy Measurement Results

Usage of Additional information from the Angular Distribution

Electroweak Precision Measurements

Total Chiral Cross Section Measurement

Anomalous Triple Gauge Couplings

Conclusion



Simultaneous Chiral Cross Section measurement

- ▶ Define the ratio R between the "actual" cross section σ_{actual} and the SM cross section σ_{SM}

$$R(\vec{x}) := \frac{\sigma_{\text{actual}}}{\sigma_{\text{SM}}}$$

- ▶ In general R can be parameterized by an arbitrary set of parameters \vec{x}

$$\begin{aligned} \delta_i \sigma^{\text{theory}}(P_{e-}, P_{e+}, \vec{x}) = & \frac{(1-P_{e-})}{2} \frac{(1+P_{e+})}{2} \cdot R_{\text{LR}}(\vec{x}) \cdot \delta_i \sigma_{\text{LR}} \\ & + \frac{(1+P_{e-})}{2} \frac{(1-P_{e+})}{2} \cdot R_{\text{RL}}(\vec{x}) \cdot \delta_i \sigma_{\text{RL}} \\ & + \frac{(1-P_{e-})}{2} \frac{(1-P_{e+})}{2} \cdot R_{\text{LL}}(\vec{x}) \cdot \delta_i \sigma_{\text{LL}} \\ & + \frac{(1+P_{e-})}{2} \frac{(1+P_{e+})}{2} \cdot R_{\text{RR}}(\vec{x}) \cdot \delta_i \sigma_{\text{RR}} \end{aligned}$$

- ▶ Introducing Pseudo Nuisance Parameters for cross section measurement

- ▶ Unpolarized Cross section scaling α :

$$\sigma_0 \longrightarrow \alpha \cdot \sigma_0 = 0.25 \cdot (\alpha \cdot \sigma_{\text{LR}} + \alpha \cdot \sigma_{\text{RL}} + \alpha \cdot \sigma_{\text{LL}} + \alpha \cdot \sigma_{\text{RR}}) \quad \alpha \in \mathbb{R}^+$$

- ▶ Asymmetry discrepancy β

$$A \longrightarrow A + \beta$$

Implementing the *Pseudo Nuisance Parameters* α , β

- ▶ The ratio R is defined as multiplicative quantity: $R(\alpha, \beta) = R(\alpha) \cdot R(\beta)$
- ▶ Calculation of $R(\alpha)$

$$R_{\text{LR}}(\vec{x}) \equiv R_{\text{RL}}(\vec{x}) \equiv R_{\text{LL}}(\vec{x}) \equiv R_{\text{RR}}(\vec{x}) \equiv \alpha$$

- ▶ Calculation of $R(\beta)$, e.g. for $A_{\text{RL}}^{\text{LR}}$, analog for other asymmetries

$$R_{\text{LR}}(\beta) := 1 + 0.5 \cdot \frac{\sigma_{\text{LR}} + \sigma_{\text{RL}}}{\sigma_{\text{LR}}} \cdot \beta \quad R_{\text{RL}}(\beta) := 1 - 0.5 \cdot \frac{\sigma_{\text{LR}} + \sigma_{\text{RL}}}{\sigma_{\text{RL}}} \cdot \beta$$

- ▶ Theoretical cross section calculation:

$$\begin{aligned} \delta_i \sigma^{\text{theory}}(P_{e^-}, P_{e^+}, \alpha, \beta) &= \frac{(1-P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \alpha \cdot \left(1 + 0.5 \cdot \frac{\sigma_{\text{LR}} + \sigma_{\text{RL}}}{\sigma_{\text{LR}}} \cdot \beta\right) \cdot \delta_i \sigma_{\text{LR}} \\ &\quad + \frac{(1+P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \alpha \cdot \left(1 - 0.5 \cdot \frac{\sigma_{\text{LR}} + \sigma_{\text{RL}}}{\sigma_{\text{RL}}} \cdot \beta\right) \cdot \delta_i \sigma_{\text{RL}} \\ &\quad + \frac{(1-P_{e^-})}{2} \frac{(1-P_{e^+})}{2} \cdot \alpha \cdot \delta_i \sigma_{\text{LL}} + \frac{(1+P_{e^-})}{2} \frac{(1+P_{e^+})}{2} \cdot \alpha \cdot \delta_i \sigma_{\text{RR}} \end{aligned}$$

- ▶ **Remark:** For each process and channel one α and β will be introduced

Polarization, Scaling Parameters α And Asymmetry Deviation β Combined

Results for statistical uncertainties only

χ^2 / NDF	727.42 / 708				
Parameter	Actual Value	Fit Value	Parameter	Actual Value	Fit Value
$P_{e^-}^- [\%]$	-80	-80.1 ± 0.038	$P_{e^+}^- [\%]$	-30	-30 ± 0.032
$P_{e^-}^+ [\%]$	80	80 ± 0.013	$P_{e^+}^+ [\%]$	30	30 ± 0.043
$\alpha_{W+}(e\nu l\nu)$	0.8	0.8 ± 0.001	$\beta_{W+}(e\nu l\nu)$	0	$(6.4 \pm 7) \cdot 10^{-4}$
$\alpha_{W-}(e\nu l\nu)$	1.1	1.1 ± 0.0012	$\beta_{W-}(e\nu l\nu)$	0	$(8.7 \pm 12) \cdot 10^{-4}$
$\alpha_{W+}(e\nu q\bar{q})$	0.79	0.79 ± 0.00066	$\beta_{W+}(e\nu q\bar{q})$	0	$(1.9 \pm 4.1) \cdot 10^{-4}$
$\alpha_{W-}(e\nu q\bar{q})$	1.2	1.198 ± 0.00087	$\beta_{W-}(e\nu q\bar{q})$	0	$(-4.6 \pm 7) \cdot 10^{-4}$
$\alpha_{WW}(\bar{q}q\bar{q}\bar{q})$	1.2	1.2 ± 0.00069	$\beta_{WW}(\bar{q}q\bar{q}\bar{q})$	0	$(-4.1 \pm 15) \cdot 10^{-5}$
$\alpha_{WW}(l\nu l\nu)$	0.78	0.78 ± 0.0011	$\beta_{WW}(l\nu l\nu)$	0	$(1 \pm 0.55) \cdot 10^{-3}$
$\alpha_{WW}(l\nu q\bar{q})$	0.9	0.9 ± 0.00052	$\beta_{WW}(l\nu q\bar{q})$	0	$(-2.8 \pm 1.5) \cdot 10^{-4}$
$\alpha_{ZZ}(q\bar{q}q\bar{q})$	1.1	1.1 ± 0.0011	$\beta_{ZZ}(q\bar{q}q\bar{q})$	0	$(5.1 \pm 120) \cdot 10^{-5}$
$\alpha_{ZZ}(llll)$	0.91	0.91 ± 0.0027	$\beta_{ZZ}(llll)$	0	-0.011 ± 0.0036
$\alpha_{ZZ}(llq\bar{q})$	1	0.999 ± 0.00098	$\beta_{ZZ}(llq\bar{q})$	0	$(-2.7 \pm 12) \cdot 10^{-4}$
$\alpha_{ZZWW}(q\bar{q}q\bar{q})$	0.93	0.93 ± 0.00058	$\beta_{ZZWW}(q\bar{q}q\bar{q})$	0	$(1.2 \pm 3) \cdot 10^{-4}$
$\alpha_{ZZWW}(l\nu l\nu)$	0.82	0.82 ± 0.0011	$\beta_{ZZWW}(l\nu l\nu)$	0	$(-2.1 \pm 0.89) \cdot 10^{-3}$
$\alpha_Z(q\bar{q})$	0.79	0.79 ± 0.00014	$\beta_Z(q\bar{q})$	0	$(-2.9 \pm 3.6) \cdot 10^{-4}$
$\alpha_Z(l^+l^-)$	0.88	0.88 ± 0.00022	$\beta_Z(l^+l^-)$	0	$(-2.8 \pm 4.6) \cdot 10^{-4}$



Polarization, Scaling Parameters α And Asymmetry Deviation β Combined

Results for statistical uncertainties only

χ^2 / NDF	727.42 / 708				
Parameter	Actual Value	Fit Value	Parameter	Actual Value	Fit Value
$P_{e^-}^- [\%]$	-80	-80.1 ± 0.038	$P_{e^+}^- [\%]$	-30	-30 ± 0.032
$P_{e^-}^+ [\%]$	80	80 ± 0.013	$P_{e^+}^+ [\%]$	30	30 ± 0.043
$\alpha_{W^+}(e\nu l\nu)$	0.8	0.8 ± 0.001	$\beta_{W^+}(e\nu l\nu)$	0	$(6.4 \pm 7) \cdot 10^{-4}$
$\alpha_{W^-}(e\nu l\nu)$	1.1	1.1 ± 0.0012	$\beta_{W^-}(e\nu l\nu)$	0	$(8.7 \pm 12) \cdot 10^{-4}$
$\alpha_{W^+}(e\nu q\bar{q})$					0^{-4}
$\alpha_{W^-}(e\nu q\bar{q})$					0^{-4}
$\alpha_{WW}(q\bar{q}q\bar{q})$					10^{-5}
$\alpha_{WW}(l\nu l\nu)$					0^{-3}
$\alpha_{WW}(l\nu q\bar{q})$					10^{-4}
$\alpha_{ZZ}(q\bar{q}q\bar{q})$					0^{-5}
$\alpha_{ZZ}(llll)$					0.036
$\alpha_{ZZ}(llq\bar{q})$	1	0.999 ± 0.00098	$\beta_{ZZ}(llqq)$	0	$(-2.7 \pm 12) \cdot 10^{-4}$
$\alpha_{ZZWW}(q\bar{q}q\bar{q})$	0.93	0.93 ± 0.00058	$\beta_{ZZWW}(q\bar{q}q\bar{q})$	0	$(1.2 \pm 3) \cdot 10^{-4}$
$\alpha_{ZZWW}(l\nu l\nu)$	0.82	0.82 ± 0.0011	$\beta_{ZZWW}(l\nu l\nu)$	0	$(-2.1 \pm 0.89) \cdot 10^{-3}$
$\alpha_Z(q\bar{q})$	0.79	0.79 ± 0.00014	$\beta_Z(q\bar{q})$	0	$(-2.9 \pm 3.6) \cdot 10^{-4}$
$\alpha_Z(l^+l^-)$	0.88	0.88 ± 0.00022	$\beta_Z(l^+l^-)$	0	$(-2.8 \pm 4.6) \cdot 10^{-4}$

- ✓ Simultaneous fit of the 4 beam polarizations and the 28 pseudo nuisance parameter possible
- ✓ All pseudo nuisance parameter correctly determined
- ✓ No effect on the polarization precision



Beam Polarization Determination via Cross Section Measurement

Introduction

Toy Measurement Results

Usage of Additional information from the Angular Distribution

Electroweak Precision Measurements

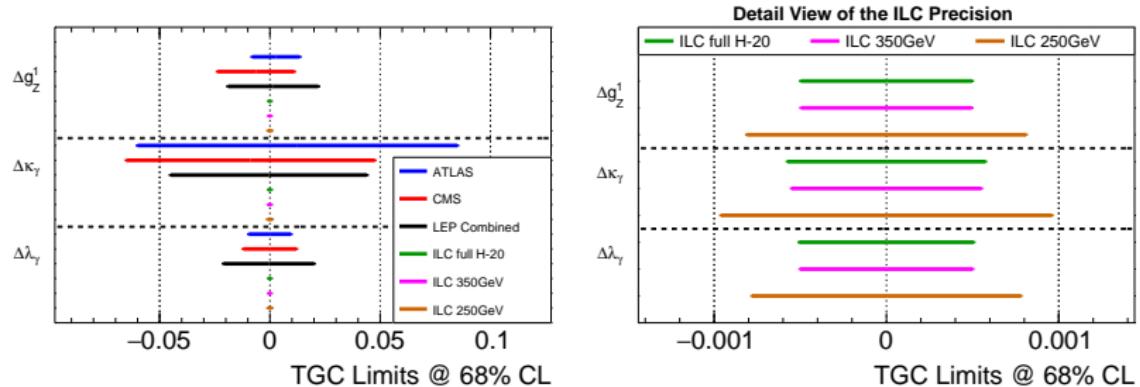
Total Chiral Cross Section Measurement

Anomalous Triple Gauge Couplings

Conclusion



ILC Extrapolation in Comparison LEP and LHC



ILD full simulation		Extrapolations		
E_{CMS}	500 GeV	250 GeV	350 GeV	H-20
Δg_1^Z	$4.3 \cdot 10^{-4}$	$8.1 \cdot 10^{-4}$	$5.0 \cdot 10^{-4}$	$5.0 \cdot 10^{-4}$
$\Delta \kappa_\gamma$	$4.4 \cdot 10^{-4}$	$9.6 \cdot 10^{-4}$	$5.5 \cdot 10^{-4}$	$5.7 \cdot 10^{-4}$
$\Delta \lambda_\gamma$	$4.1 \cdot 10^{-4}$	$7.8 \cdot 10^{-4}$	$5.0 \cdot 10^{-4}$	$5.1 \cdot 10^{-4}$

LEP combined from ALEPH, L3 and OPAL

[arXiv:1708.08912]

LHC TGC limits for $\sqrt{s} = 8$ TeV data,

$\mathcal{L}_I = 20.3 \text{ fb}^{-1} (19.4 \text{ fb}^{-1})$ for ATLAS (CMS)

Direct Study of TGC Precision at 250 GeV

Determination of the TGC within an Effective Field Theory (EFT):

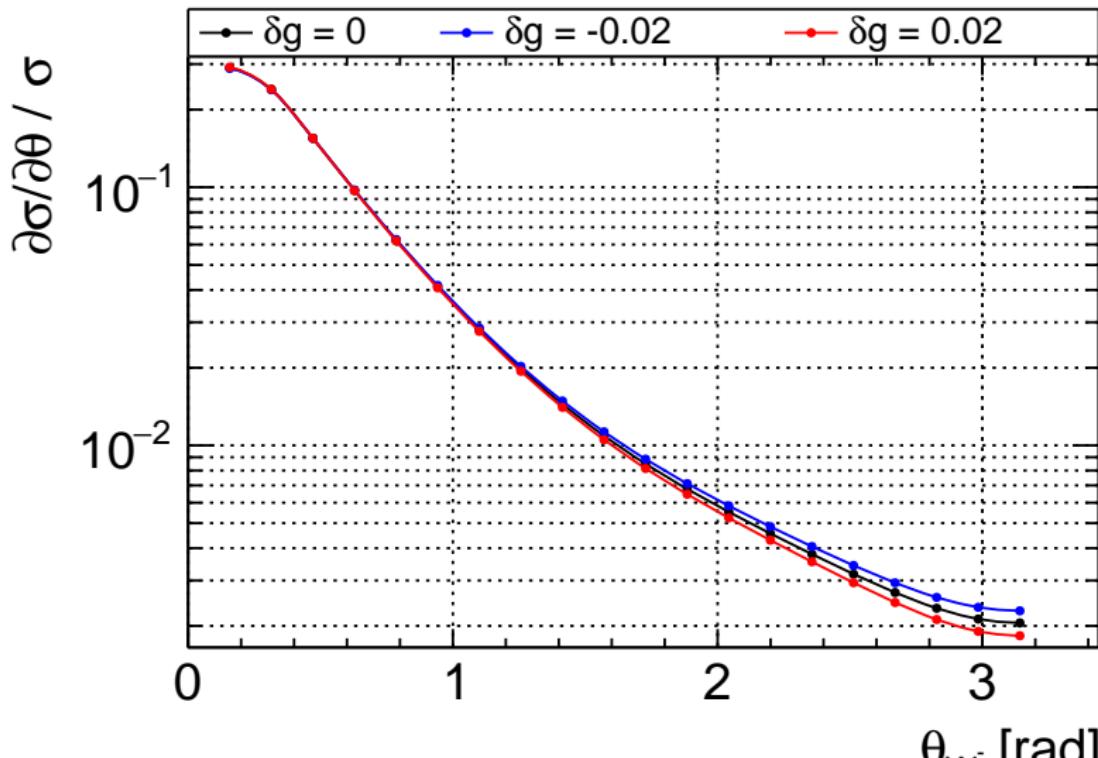
$$\begin{aligned} R(\delta g, \delta \kappa, \delta \lambda) = & 1 + A \cdot \delta g + B \cdot \delta \kappa + C \cdot \delta \lambda + D \cdot \delta g^2 + E \cdot \delta \kappa^2 + F \cdot \delta \lambda^2 \\ & + G \cdot \delta g \cdot \delta \kappa + H \cdot \delta g \cdot \delta \lambda + I \cdot \delta \kappa \cdot \delta \lambda \end{aligned}$$

Determination of A, B, \dots with 9 different MC-Samples (R_0 only for reference):

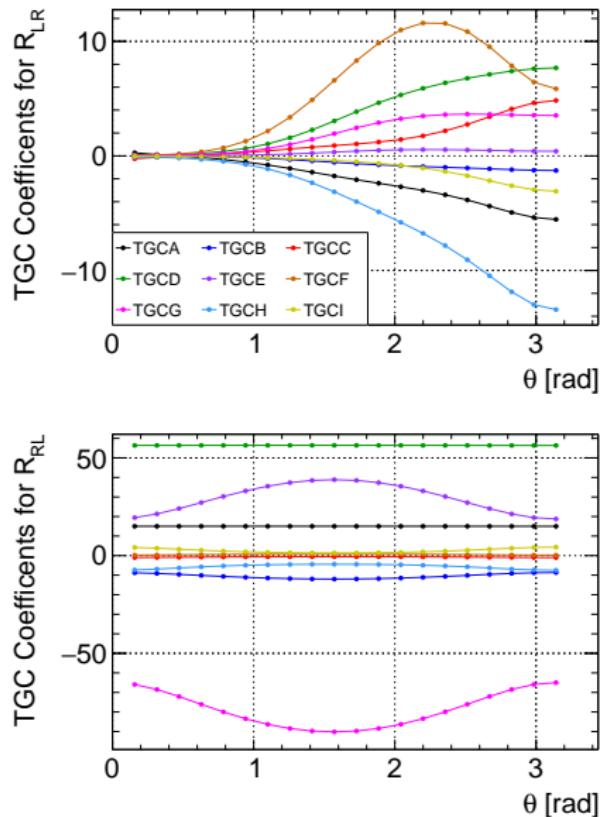
TGC	R_0	R_1	R_2	R_3	R_4	R_5	R_6	R_7	R_8	R_9
δg	0	+ δx	0	0	- δx	0	0	+ δx	0	+ δx
$\delta \kappa$	0	0	+ δx	0	0	- δx	0	+ δx	+ δx	0
$\delta \lambda$	0	0	0	+ δx	0	0	- δx	0	+ δx	+ δx

$$\delta x > 0$$

LEP Limit: $\delta x \approx 0.02$

Effect of TGC g_1^Z WW semileptonic $e_L^- e_R^+$ at 250 GeV

TGC Coefficients



- ▶ Study the change of the differential cross section for W-pair production in the semileptonic channel
- ▶ In this channel using the cross section dependence of
 - ▶ Polar angle of the $W^- \theta_{W^-}$
 - ▶ Polar angle of the charged lepton θ_l^*
 - ▶ Azimuth angle of the charged lepton φ_l^*
 - ▶ θ_l^* and φ_l^* are measured in the rest-frame of the W
- ▶ With a respective binning of $20 \times 10 \times 10$
- ▶ Left plots shows the projection of the TGC coefficients on the θ_{W^-} axis

First Results for Statistical Precision of the TGC Measurement

Using the following parameter values:

$$\begin{aligned}\varepsilon &= 0.6 & \pi &= \frac{D - \mathfrak{B}}{D} = 0.8 \\ \mathcal{L} &= 2 \text{ ab}^{-1} & \Delta\varepsilon = \Delta\pi = \Delta\mathcal{L} &= 0\end{aligned}$$

Luminosity sharing:

($-+$: 45%, $+-$: 45%, $--$: 5%, $++$: 5%)

Used with the following channels:

process	channel	bins	TGC
W-pair	semileptonic	2000	yes
s-channel Z	leptonic	20	no
	hadronic	20	no

Polarization precision in $[10^{-3}]$

$$\Delta P_{e^-}^- / P = 0.89$$

$$\Delta P_{e^-}^+ / P = 0.37$$

$$\Delta P_{e^+}^- / P = 0.99$$

$$\Delta P_{e^+}^+ / P = 1.5$$

TGC precision in $[10^{-4}]$

Fit Results:	Theoretical limit*
--------------	--------------------

$$\Delta g = 11.9 \quad | \quad \Delta g = 4.14$$

$$\Delta \kappa = 14.9 \quad | \quad \Delta \kappa = 6.22$$

$$\Delta \lambda = 22.4 \quad | \quad \Delta \lambda = 3.74$$

* Theoretical limit is calculated on MC level with Optimal Observables



Outlook

- ▶ Current results are preliminary
 - ▶ Still work in progress → Realistic description on systematic uncertainties needed
 - ▶ Currently very promising results, but the reference is till the extrapolation
$$\Delta g_1^Z = 8.1 \cdot 10^{-4} \quad \Delta \kappa_\gamma = 9.6 \cdot 10^{-4} \quad \Delta \lambda_\gamma = 7.8 \cdot 10^{-4}$$
- ▶ Include differential cross sections for more processes for polarization constraint
(e.g. Z -pair production)
- ▶ Include TGC dependence for more channels:
 - ▶ W pair hadronic: $e^+ e^- \rightarrow q\bar{q}q\bar{q}$
 - ▶ single W^+ semileptonic: $e^+ e^- \rightarrow q\bar{q}e^+\nu$
 - ▶ single W^- semileptonic: $e^+ e^- \rightarrow q\bar{q}e^-\nu$
- ▶ Combination with the other nuisance parameters α, β



Conclusion

- ▶ **Beam Polarization Determination via Cross Section Measurement**
 - ▶ The framework works perfectly
 - ▶ Non-perfect helicity reversal, correlations of systematics and angular information are included
- ▶ **Electroweak Precision Measurements**
 - ▶ Simultaneous measurement of unpolarized cross section, the left-right asymmetry and the beam polarization works perfectly
 - ▶ Simultaneous measurement of TGCs is implemented for $e^+ e^- \rightarrow q\bar{q}\mu\nu$ channel and the study is ongoing
- ▶ **Remarks:**
 - ▶ Including the polarimeter information still yields an improvement on the precision, especially for low luminosity runs
 - ▶ A test of the framework on "real" data still has to be done



Backup Slides



Coefficient Calculation

$$R(\delta g, \delta\kappa, \delta\lambda) = 1 + A \cdot \delta g + B \cdot \delta\kappa + C \cdot \delta\lambda + D \cdot \delta g^2 + E \cdot \delta\kappa^2 + F \cdot \delta\lambda^2 \\ + G \cdot \delta g \cdot \delta\kappa + H \cdot \delta g \cdot \delta\lambda + I \cdot \delta\kappa \cdot \delta\lambda$$

$$R_1 = 1 + A \cdot \delta x + D \cdot \delta x^2$$

$$A = 0.5 \cdot (R_1 - R_4) / \delta x$$

$$R_2 = 1 + B \cdot \delta x + E \cdot \delta x^2$$

$$B = 0.5 \cdot (R_2 - R_5) / \delta x$$

$$R_3 = 1 + C \cdot \delta x + F \cdot \delta x^2$$

$$C = 0.5 \cdot (R_3 - R_6) / \delta x$$

$$R_4 = 1 - A \cdot \delta x + D \cdot \delta x^2$$

$$D = 0.5 \cdot (R_1 + R_4 - 2) / \delta x^2$$

$$R_5 = 1 - B \cdot \delta x + E \cdot \delta x^2$$

$$E = 0.5 \cdot (R_2 + R_5 - 2) / \delta x^2$$

$$R_6 = 1 - C \cdot \delta x + F \cdot \delta x^2$$

$$F = 0.5 \cdot (R_3 + R_6 - 2) / \delta x^2$$

$$R_7 = 1 + A \cdot \delta x + B \cdot \delta x \\ + D \cdot \delta x^2 + E \cdot \delta x^2 + G \cdot \delta x^2$$

$$G = (R_7 - R_1 - R_2 + 1) / \delta x^2$$

$$R_8 = 1 + B \cdot \delta x + C \cdot \delta x \\ + E \cdot \delta x^2 + F \cdot \delta x^2 + I \cdot \delta x^2$$

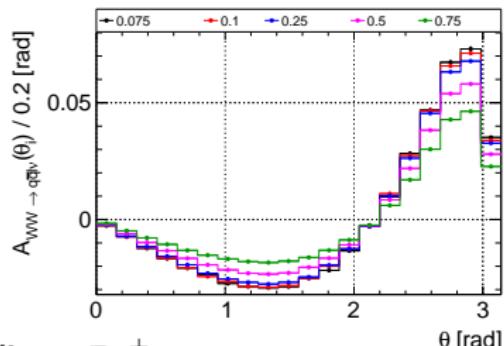
$$I = (R_8 - R_2 - R_3 + 1) / \delta x^2$$

$$R_9 = 1 + A \cdot \delta x + C \cdot \delta x \\ + D \cdot \delta x^2 + F \cdot \delta x^2 + H \cdot \delta x^2$$

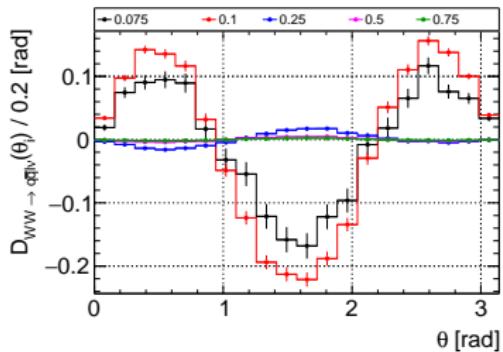
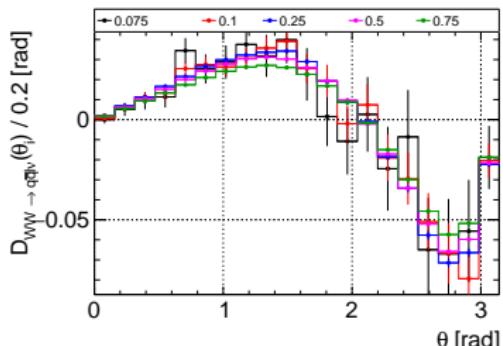
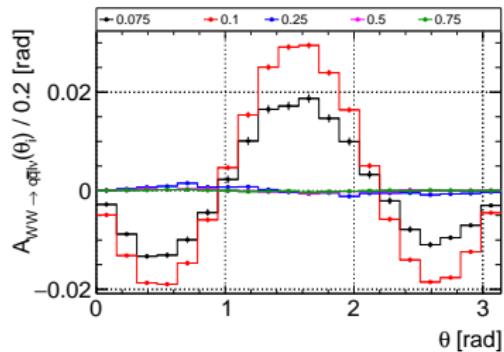
$$H = (R_9 - R_1 - R_3 + 1) / \delta x^2$$

TGC Coefficient from MC Samples

Chirality: $e_L^- e_R^+$



Chirality: $e_R^- e_L^+$



The Problem:

- ▶ In fact A is a 5D-histogram \rightarrow the precision per bin of $\mathbf{R}_1 - \mathbf{R}_4$ is too small because of too less MC statistics
- ▶ How many MC events do we need?

$$\begin{aligned} \Delta A/A = 1\% &\rightarrow \mathcal{O}(A) \approx 0.05 & \rightarrow \Delta A = 5 \cdot 10^{-4} \\ \Delta(R_1 - R_4) = 2 \cdot \underbrace{\delta x}_{\approx 0.01} \cdot \Delta A &= 10^{-5} = 1/\sqrt{N} & \rightarrow N = 10^{10} \end{aligned}$$

- ▶ ΔA calculated only for 1D \rightarrow 5D gives an additional factor of $\approx 10^4$
- ▶ $N \approx 10^{14} \rightarrow \mathcal{O}(100\text{byte}/\text{event}) \rightarrow \approx 10 \text{ petabyte MC data}$
- ▶ Use Complete DESY Bird Cluster \rightarrow 10 terabyte / day $\rightarrow \approx 2.7 \text{ years}$
- ⇒ Using MC does not work!



The Solution: Using Omega (WHIZARD) directly

- ▶ WHIZARD Event Generation:
 1. Start with the matrix element calculation performed by Omega
 2. Use matrix elements to calculate probability distributions
 3. Get random events following the probability distributions
- ▶ Instead of MC events using direct the matrix element to calculate the distributions
 - ▶ Calculating matrix element as a function of different angles (neglecting ISR and beam spectrum)
 - ▶ TGC are implemented as free parameters in Omega
- ▶ Compare it with the distribution of MC data
 - Study effects of ISR and beam spectrum
- ▶ Implementing TGC measurement in the current framework
 - Same as for my Pseudo Nuisance Parameter α, β



Electroweak Precision Measurements

Anomalous Triple Gauge Couplings

TGC Extrapolation from 500 GeV to 250 GeV



TGC Extrapolation from 500 GeV to 250 GeV

► Concept in a Nutshell:

1. 2 reference points:
@ $\sqrt{s} = 500 \text{ GeV}$ (Ivan Marchesini) and @ $\sqrt{s} = 1 \text{ TeV}$ (Aura Rosca)
2. Take result for 500 GeV and extrapolate it to 1 TeV
3. Compare it with the 1 TeV and adjust the extrapolation, if necessary
4. Use final extrapolation to calculate expected precision at 250 GeV

► Scaling of an arbitrary uncertainty Δx by a factor f

$$\Delta x(\sqrt{s}) = f(\sqrt{s}) \cdot \Delta x(500 \text{ GeV})$$

$$f(\sqrt{s}) = f_{\text{theory}}(\sqrt{s}) \cdot f_{\text{stat}}(\sqrt{s}) \cdot f_{\text{det}}(\sqrt{s})$$

► Scaling parameter determination (overview):

$$f_{\text{theory}}(\sqrt{s}) = \frac{(500 \text{ GeV})^2}{s}: \quad \text{BSM sensitivity scales with } m_W^2/s$$

$$f_{\text{statistic}}(\sqrt{s}) = \sqrt{\frac{N(500 \text{ GeV})}{N(\sqrt{s})}}: \quad \text{Statistical uncertainty scales with } 1/\sqrt{N}$$

$$f_{\text{detector}}(\sqrt{s}) \approx 1: \quad \text{ignored (at the moment)}$$



Calculation of the Scaling Factor @ $\sqrt{s} = 1 \text{ TeV}$

- Theoretical contribution:

$$f_{\text{theory}}(1 \text{ TeV}) = \frac{(500 \text{ GeV})^2}{(1 \text{ TeV})^2} = 0.25$$

- Statistical contribution:

$$f_{\text{stat}}(\sqrt{s}) = \sqrt{\frac{\mathcal{L}(500 \text{ GeV}) \cdot \sigma(500 \text{ GeV})}{\mathcal{L}(1 \text{ TeV}) \cdot \sigma(1 \text{ TeV})}} \approx 1.08$$

- Comparison with the actual ratio:

$$f(1 \text{ TeV}) = 1.08 \cdot 0.25 = 0.27$$

$$\frac{\text{TGC}_{\text{Aura}}}{\text{TGC}_{\text{Ivan}}} : \quad \frac{\Delta g_{1 \text{ TeV}}}{\Delta g_{500 \text{ GeV}}} = 0.31 \quad \frac{\Delta \kappa_{1 \text{ TeV}}}{\Delta \kappa_{500 \text{ GeV}}} = 0.27 \quad \frac{\Delta \lambda_{1 \text{ TeV}}}{\Delta \lambda_{500 \text{ GeV}}} = 0.37$$



Determination of $f_{\text{det},i}(\sqrt{s})$

Calculating $f_{\text{det},i}$ using the TeV results:

$$f_{\text{det},\Delta g}(1 \text{ TeV}) = \frac{\Delta g_{1 \text{ TeV}}}{\Delta g_{500 \text{ GeV}}} / (f_{\text{theo}}(1 \text{ TeV}) \cdot f_{\text{stat}}(1 \text{ TeV}; 1, \text{ab}^{-1})) = 0.31/0.27 = 1.15$$

$$f_{\text{det},\Delta \kappa}(1 \text{ TeV}) = \frac{\Delta \kappa_{1 \text{ TeV}}}{\Delta \kappa_{500 \text{ GeV}}} / (f_{\text{theory}}(1 \text{ TeV}) \cdot f_{\text{stat}}(1 \text{ TeV}; 1, \text{ab}^{-1})) = 0.27/0.27 = 1$$

$$f_{\text{det},\Delta \lambda}(1 \text{ TeV}) = \frac{\Delta \lambda_{1 \text{ TeV}}}{\Delta \lambda_{500 \text{ GeV}}} / (f_{\text{theo}}(1 \text{ TeV}) \cdot f_{\text{stat}}(1 \text{ TeV}; 1, \text{ab}^{-1})) = 0.37/0.27 = 1.37$$

Extrapolation $f_{\text{det},i}$ to 250 GeV

$$f_{\text{det},\Delta g}(250 \text{ GeV}) = (f_{\text{det},\Delta g}(1 \text{ TeV}))^{-1} = 1.15^{-1} = 0.87$$

$$f_{\text{det},\Delta \kappa}(250 \text{ GeV}) = (f_{\text{det},\Delta \kappa}(1 \text{ TeV}))^{-1} = 1^{-1} = 1$$

$$f_{\text{det},\Delta \lambda}(250 \text{ GeV}) = (f_{\text{det},\Delta \lambda}(1 \text{ TeV}))^{-1} = 1.37^{-1} = 0.73$$

Extrapolation to $\sqrt{s} = 250 \text{ GeV}$

$$f_{\text{stat}}(250 \text{ GeV}, 2000 \text{ fb}^{-1}) = \sqrt{\frac{500 \text{ fb}^{-1} \cdot (9521.45 \text{ fb} + 45.58 \text{ fb})}{2000 \text{ fb}^{-1} \cdot (18781.00 \text{ fb} + 172.73 \text{ fb})}} \approx 0.355$$

$$f_{\text{theo}}(250 \text{ GeV}) = \frac{(500 \text{ GeV})^2}{(250 \text{ GeV})^2} = 4$$

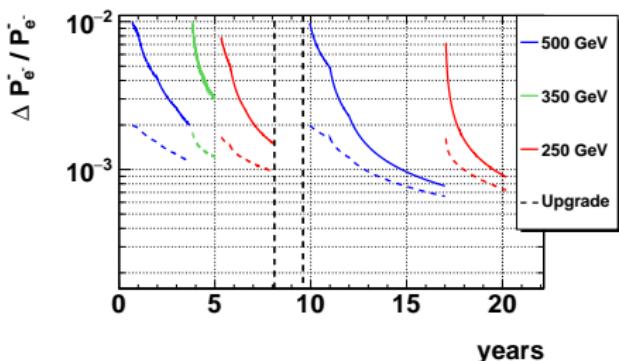
$$\begin{aligned} \Delta g(250 \text{ GeV}, 2 \text{ ab}^{-1}) &= f_{\text{theo}}(250 \text{ GeV}) \cdot f_{\text{stat}}(250 \text{ GeV}, 2 \text{ ab}^{-1}) \cdot f_{\text{det}, \Delta g}(250 \text{ GeV}) \cdot \Delta g(500 \text{ GeV}) \\ &= 4 \cdot 0.355 \cdot 0.87 \cdot 6.1 \cdot 10^{-4} = \underline{7.5 \cdot 10^{-4}} \end{aligned}$$

$$\begin{aligned} \Delta \kappa(250 \text{ GeV}, 2 \text{ ab}^{-1}) &= f_{\text{theo}}(250 \text{ GeV}) \cdot f_{\text{stat}}(250 \text{ GeV}, 2 \text{ ab}^{-1}) \cdot f_{\text{det}, \Delta \kappa}(250 \text{ GeV}) \cdot \Delta \kappa(500 \text{ GeV}) \\ &= 4 \cdot 0.355 \cdot 1 \cdot 6.4 \cdot 10^{-4} = \underline{9.1 \cdot 10^{-4}} \end{aligned}$$

$$\begin{aligned} \Delta \lambda(250 \text{ GeV}, 2 \text{ ab}^{-1}) &= f_{\text{theo}}(250 \text{ GeV}) \cdot f_{\text{stat}}(250 \text{ GeV}, 2 \text{ ab}^{-1}) \cdot f_{\text{det}}(250 \text{ GeV}) \cdot \Delta \lambda(500 \text{ GeV}) \\ &= 4 \cdot 0.355 \cdot 0.73 \cdot 7.2 \cdot 10^{-4} = \underline{7.5 \cdot 10^{-4}} \end{aligned}$$



Consider Constraints from the Polarimeter Measurement



Simplified approach: (as a first step)

- ▶ Neglect spin transport
- ▶ Using $\Delta P/P = 0.25\%$:
- ▶ Gaussian distribution
 - ▶ Mean: $|P_{e-}| = 80\%$, $|P_{e+}| = 30\%$
 - ▶ Width: ΔP

E	500	350	250	500	250
\mathcal{L}	500	200	500	3500	1500
Without Constraint					
P_{e-}^-	0.2	0.3	0.1	0.08	0.09
With Constraint					
P_{e-}^-	0.1	0.1	0.1	0.07	0.07

Implementation:

$$\chi^2_+ = \sum_P \left[\frac{(P_{e^\pm}^\pm - \mathcal{P}_{e^\pm}^\pm)^2}{\Delta \mathcal{P}^2} \right]$$

- ▶ $P_{e^\pm}^\pm$: 4 fitted parameters
- ▶ $\mathcal{P}_{e^\pm}^\pm$: Polarimeter measurement
- ▶ $\Delta \mathcal{P}$: Polarimeter uncertainty